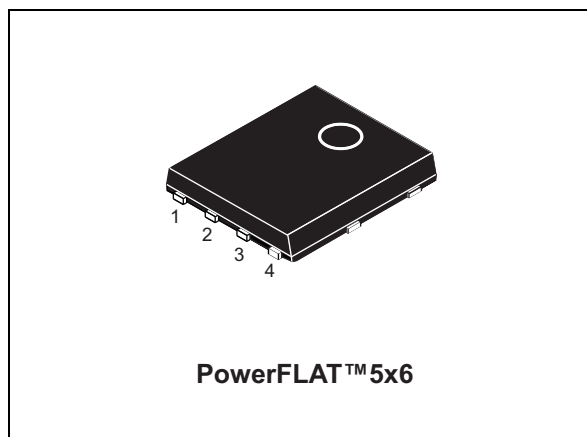


## N-channel 30 V, 0.0038 $\Omega$ typ., 24 A STripFET™ VI DeepGATE™ Power MOSFET in PowerFLAT™ 5x6 package

Datasheet - production data



### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STL90N3LLH6	30 V	0.0045 $\Omega$	24 A (1)

1. The value is rated according R<sub>thj-pcb</sub>

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET developed using the 6<sup>th</sup> generation of STripFET™ DeepGATE™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

Figure 1. Internal schematic diagram

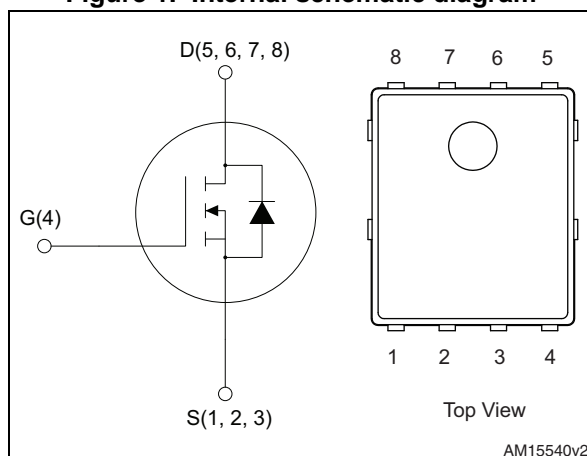


Table 1. Device summary

Order code	Marking	Packages	Packaging
STL90N3LLH6	90N3LLH6	PowerFLAT™ 5x6	Tape and reel

Contents

1      **Electrical ratings** ..... 3

2      **Electrical characteristics** ..... 4

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3      **Test circuits** ..... 8

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	30	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25\text{ }^{\circ}\text{C}$	90	A
$I_D^{(1)}$	Drain current (continuous) at $T_C = 70\text{ }^{\circ}\text{C}$	67.5	A
$I_D^{(1)}$	Drain current (continuous) at $T_C = 100\text{ }^{\circ}\text{C}$	56.2	A
$I_D^{(2)}$	Drain current (continuous) at $T_{pcb} = 25\text{ }^{\circ}\text{C}$	24	A
$I_D^{(2)}$	Drain current (continuous) at $T_{pcb} = 70\text{ }^{\circ}\text{C}$	18	A
$I_D^{(2)}$	Drain current (continuous) at $T_{pcb} = 100\text{ }^{\circ}\text{C}$	15	A
$I_{DM}^{(2)(3)}$	Drain current (pulsed)	96	A
$I_{DM}^{(1)(3)}$	Drain current (pulsed)	360	A
$P_{TOT}^{(1)}$	Total dissipation at $T_C = 25\text{ }^{\circ}\text{C}$	60	W
$P_{TOT}^{(2)}$	Total dissipation at $T_{pcb} = 25\text{ }^{\circ}\text{C}$	4	W
	Derating factor	0.03	W/ $^{\circ}\text{C}$
$T_J$	Operating junction temperature	-55 to 150	$^{\circ}\text{C}$
$T_{stg}$	Storage temperature		

1. The value is rated according to  $R_{thj-c}$
2. The value is rated according to  $R_{thj-pcb}$
3. Pulse width limited by safe operating area

**Table 3. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case (drain, steady state)	2.08	$^{\circ}\text{C}/\text{W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-ambient	31.3	$^{\circ}\text{C}/\text{W}$

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu,  $t < 10\text{ sec}$

**Table 4. Avalanche characteristics**

Symbol	Parameter	Value	Unit
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25\text{ }^{\circ}\text{C}$ , $I_D = 12\text{ A}$ ; $L = 1.25\text{ mH}$ )	90	mJ

## 2 Electrical characteristics

( $T_{CASE} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified)

**Table 5. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250\text{ }\mu\text{A}$ , $V_{GS} = 0$	30			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 30\text{ V}$ ,			1	$\mu\text{A}$
		$V_{DS} = 30\text{ V}$ $T_C = 125\text{ }^{\circ}\text{C}$			10	$\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20\text{ V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$	1	1.7	2.5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$ , $I_D = 12\text{ A}$		0.0038	0.0045	$\Omega$
		$V_{GS} = 4.5\text{ V}$ , $I_D = 12\text{ A}$		0.0057	0.0073	$\Omega$

**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0$	1350	1690	2030	pF
$C_{oss}$	Output capacitance		230	290	350	pF
$C_{rss}$	Reverse transfer capacitance		140	176	210	pF
$Q_g$	Total gate charge	$V_{DD} = 15\text{ V}$ , $I_D = 24\text{ A}$ $V_{GS} = 4.5\text{ V}$ (see Figure 14)		17		nC
$Q_{gs}$	Gate-source charge			8		nC
$Q_{gd}$	Gate-drain charge			6		nC
$R_G$	Gate input resistance	$f = 1\text{ MHz}$ Gate DC Bias = 0 Test signal level = 20 mV open drain	1.25	1.7	2	$\Omega$

**Table 7. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15\text{ V}$ , $I_D = 12\text{ A}$ , $R_G = 4.7\text{ }\Omega$ , $V_{GS} = 10\text{ V}$ (see Figure 13)	-	9.5	-	ns
$t_r$	Rise time		-	30	-	ns
$t_{d(off)}$	Turn-off delay time		-	37	-	ns
$t_f$	Fall time		-	12	-	ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		24	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		96	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 24\text{ A}$ , $V_{GS}=0$	-		1.1	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 12\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $V_{DD}=25\text{ V}$	-	24		ns
$Q_{rr}$	Reverse recovery charge		-	16.8		nC
$I_{RRM}$	Reverse recovery current		-	1.4		A

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300 $\mu$ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

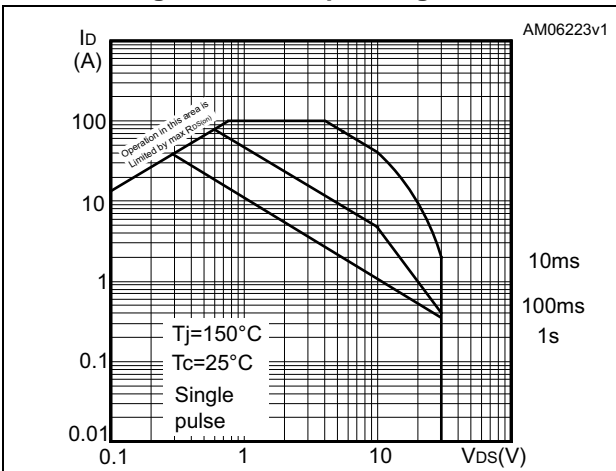


Figure 3. Thermal impedance

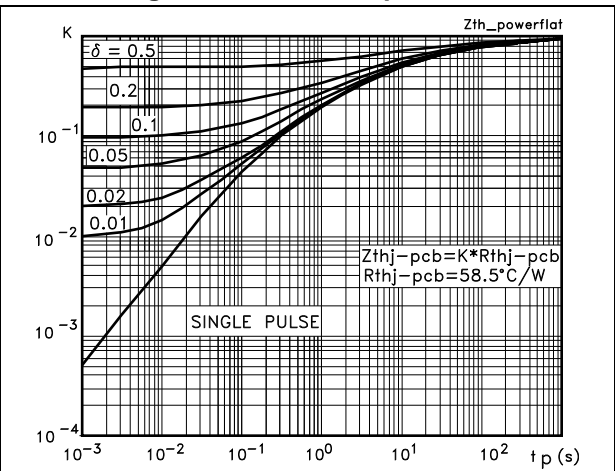


Figure 4. Output characteristics

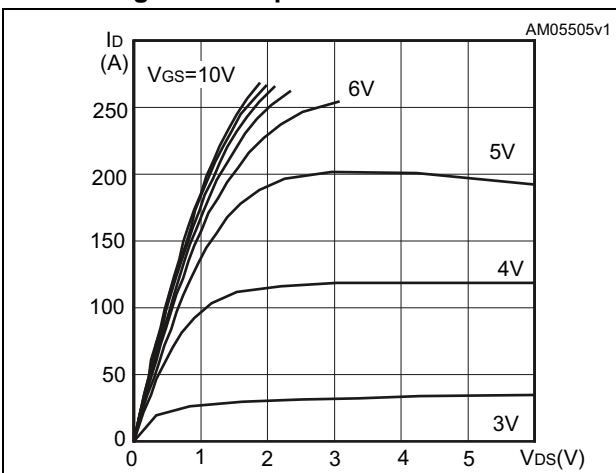


Figure 5. Transfer characteristics

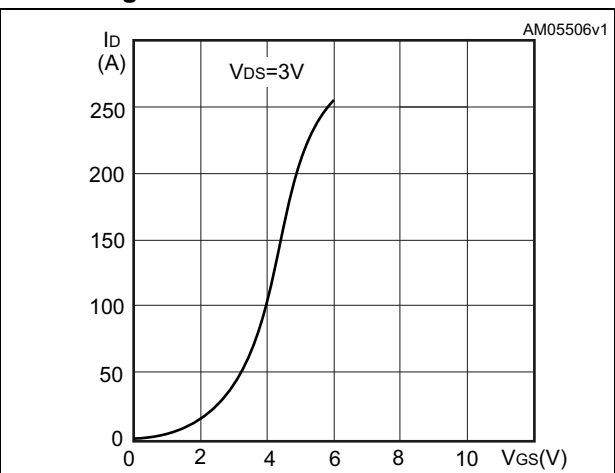


Figure 6. Normalized BV<sub>DSS</sub> vs temperature

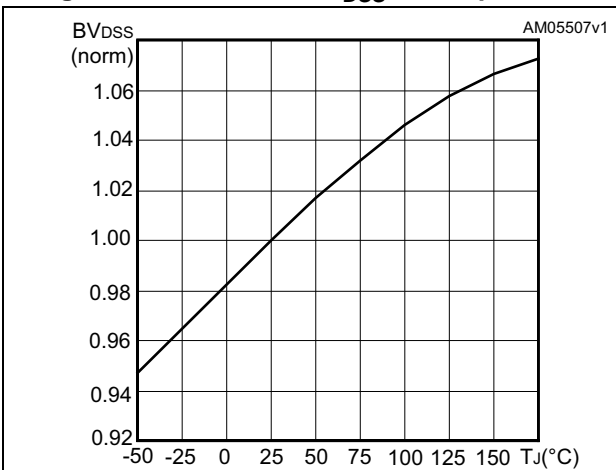


Figure 7. Static drain-source on-resistance

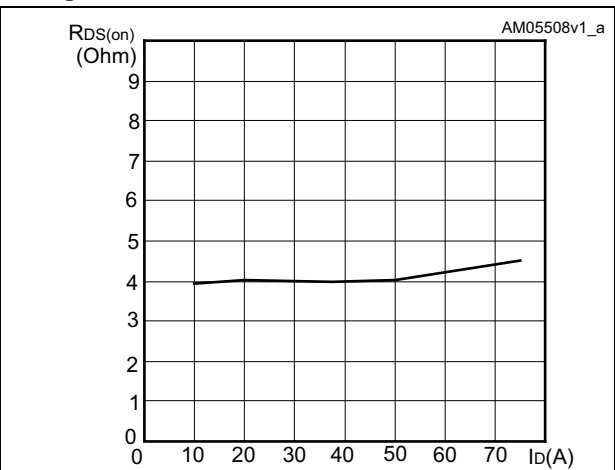


Figure 8. Gate charge vs gate-source voltage

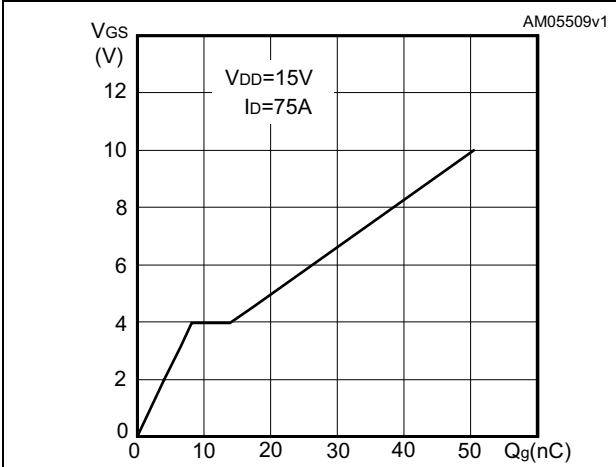


Figure 9. Capacitance variations

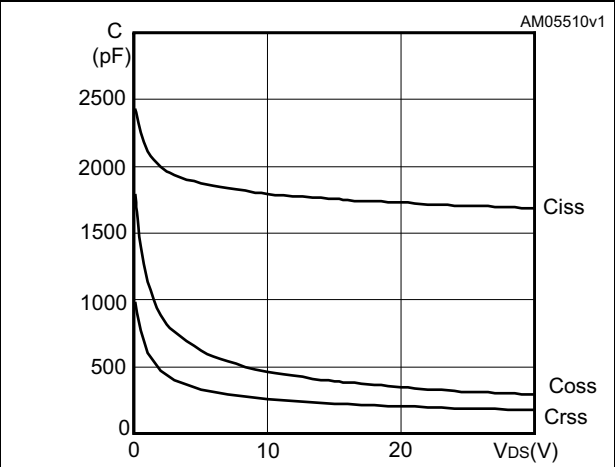


Figure 10. Normalized gate threshold voltage vs temperature

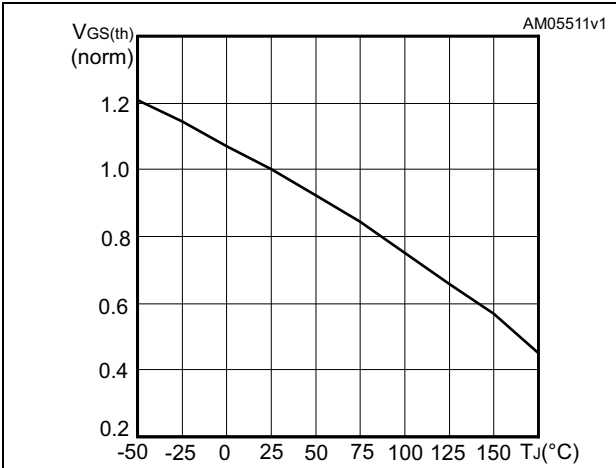


Figure 11. Normalized on-resistance vs temperature

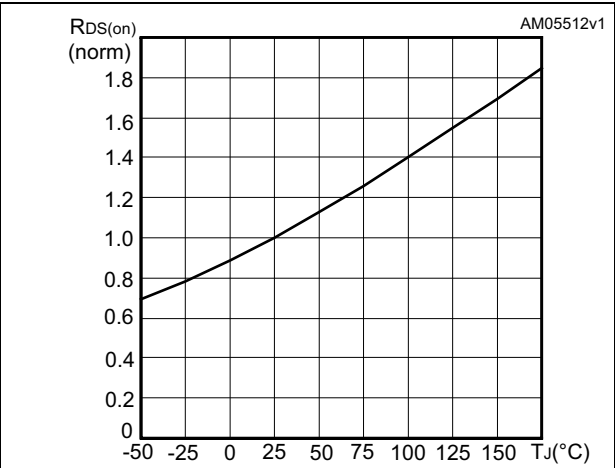
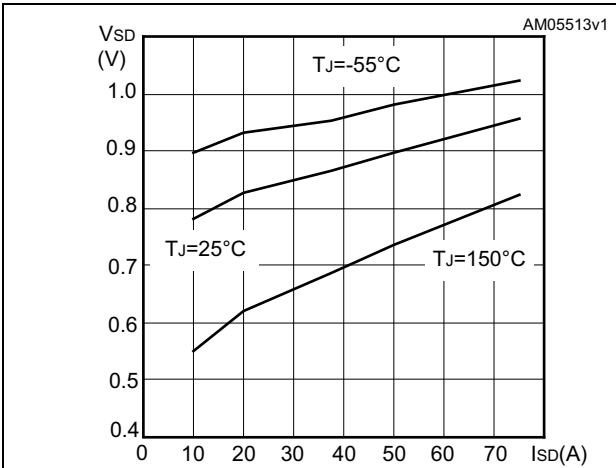


Figure 12. Source-drain diode forward characteristics



### 3 Test circuits

Figure 13. Switching times test circuit for resistive load

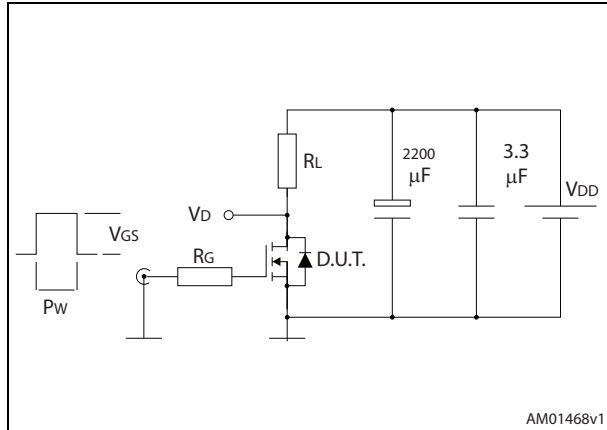


Figure 14. Gate charge test circuit

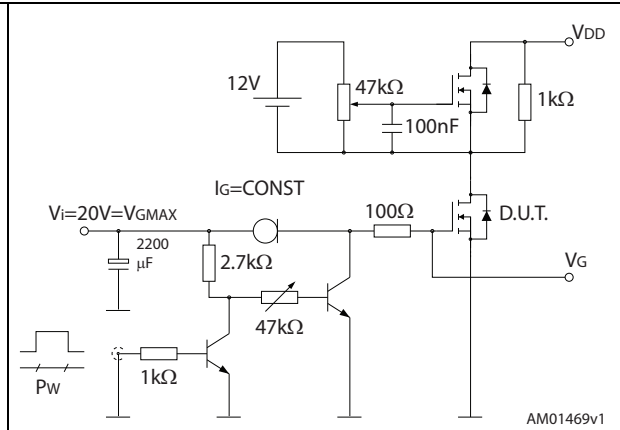


Figure 15. Test circuit for inductive load switching and diode recovery times

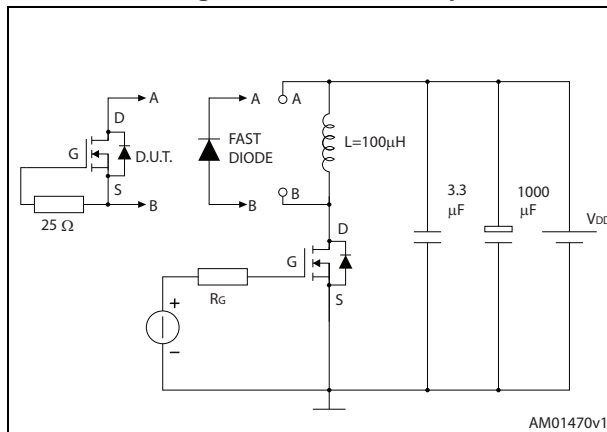


Figure 16. Unclamped inductive load test circuit

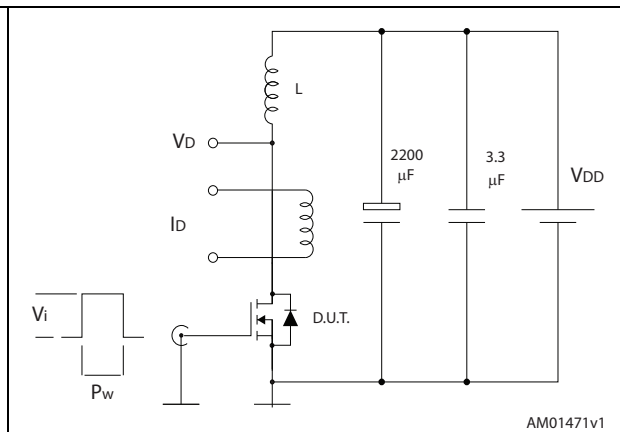


Figure 17. Unclamped inductive waveform

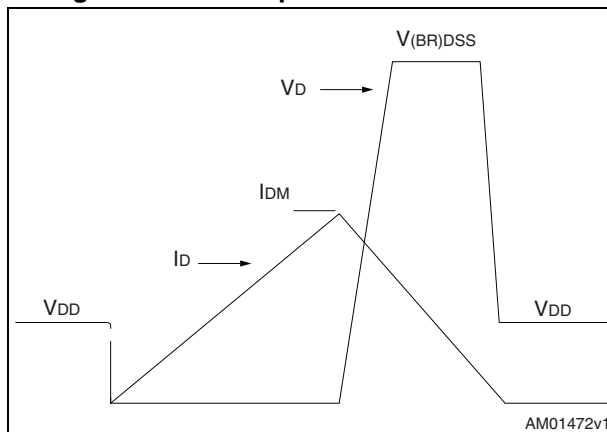
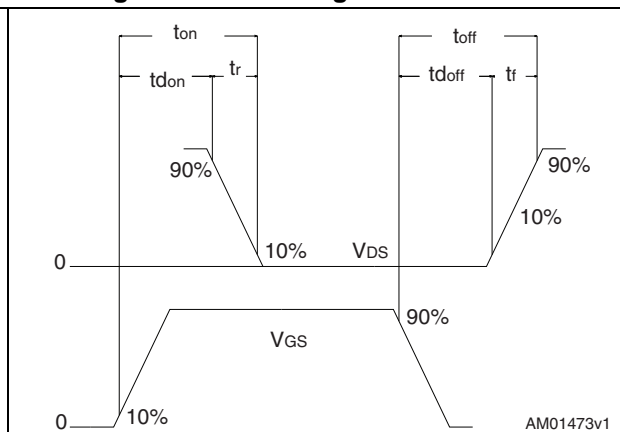


Figure 18. Switching time waveform





## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

Table 9. PowerFLAT™ 5x6 type C-B mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80	0.83	0.93
A1	0	0.02	0.05
A3		0.20	
b	0.35	0.40	0.47
D		5.00	
D1		4.75	
D2	4.15	4.20	4.25
E		6.00	
E1		5.75	
E2	3.43	3.48	3.53
E4	2.58	2.63	2.68
e		1.27	
L	0.70	0.80	0.90

Figure 19. PowerFLAT™ 5x6 type C-B drawing

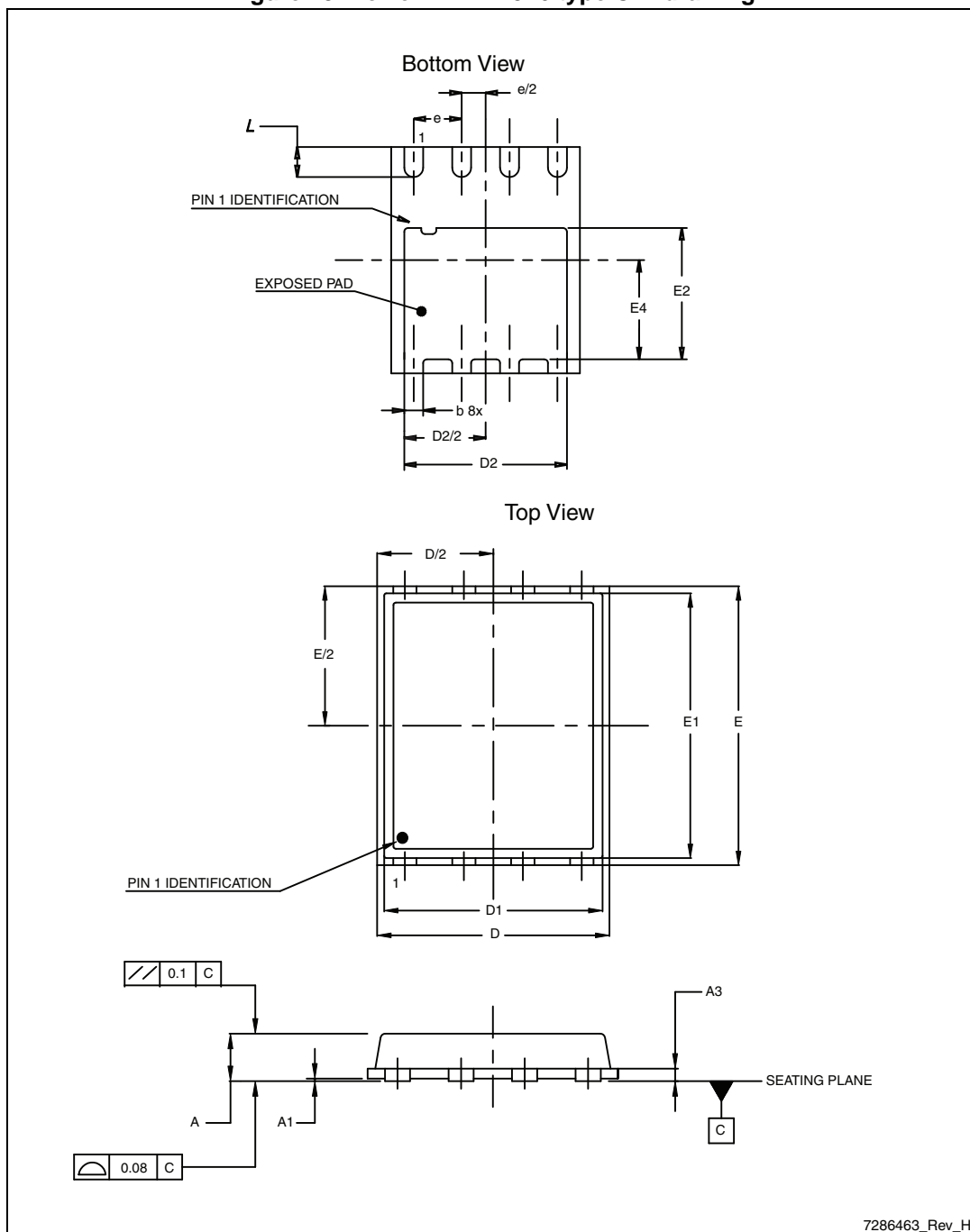


Table 10. PowerFLAT™ 5x6 type S-C mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D		5.20	
E		6.15	
D2	4.11		4.31
E2	3.50		3.70
e		1.27	
e1		0.65	
L	0.715		1.015
K	1.05		1.35

Figure 20. PowerFLAT™ 5x6 type S-C mechanical data

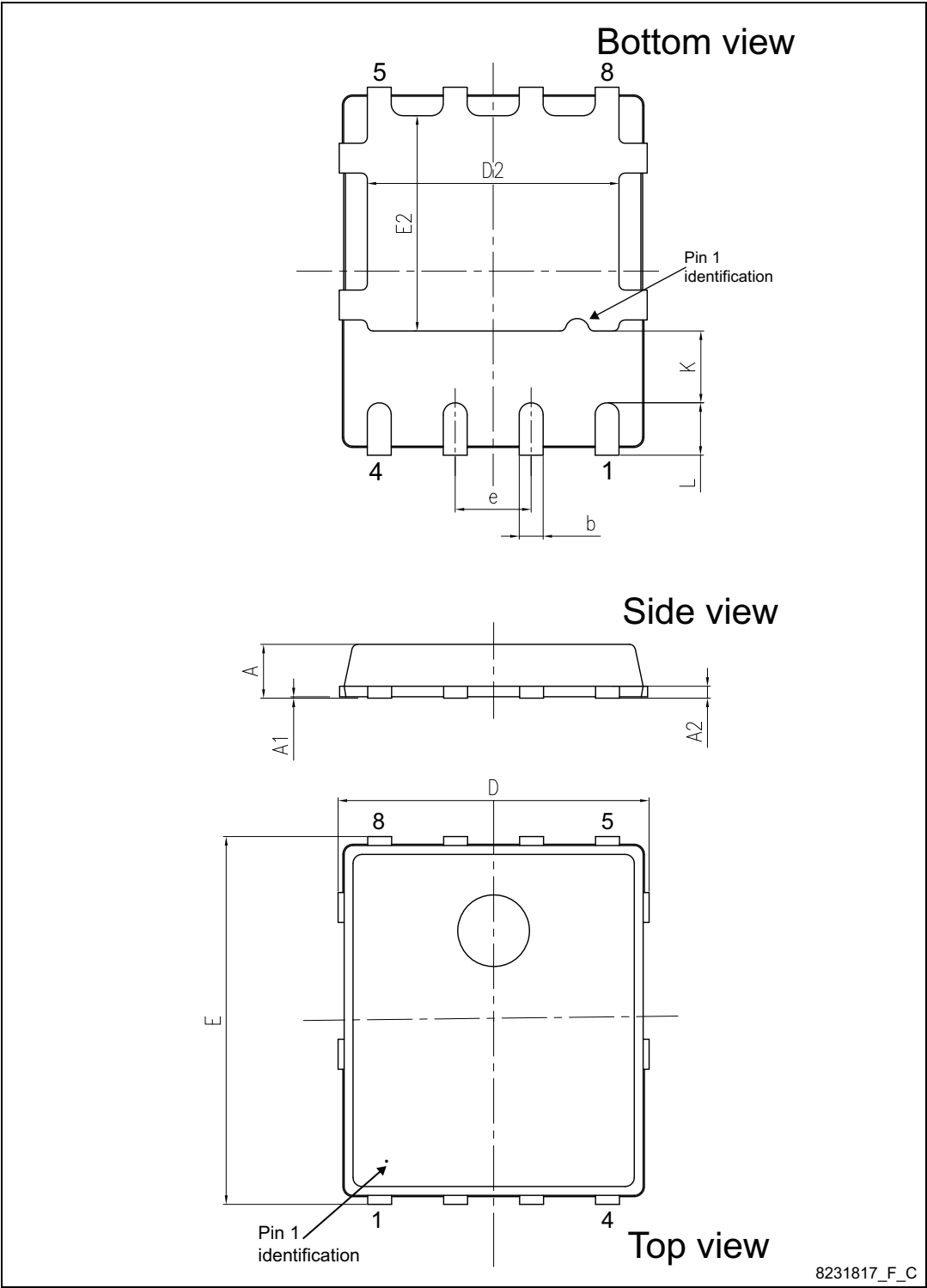
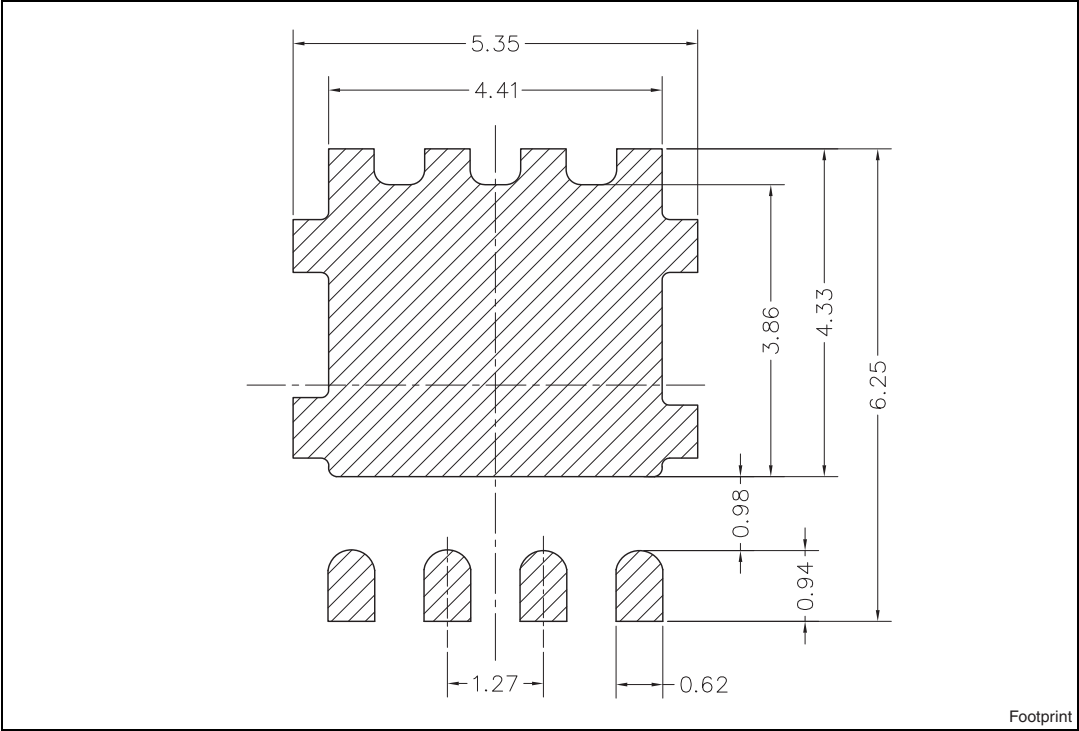


Figure 21. PowerFLAT™ 5x6 recommended footprint (dimensions in mm)



## 5 Revision history

Table 11. Document revision history

Date	Revision	Changes
10-Apr-2009	1	First release
17-Mar-2010	2	– Inserted new values on <a href="#">Table 5</a> , <a href="#">Table 6</a> and <a href="#">Table 8</a> – Document status promoted from preliminary data to datasheet.
10-Nov-2011	3	Inserted $I_D$ value @ 70 °C, in <a href="#">Table 2: Absolute maximum ratings</a> . <a href="#">Section 4: Package mechanical data</a> has been updated. Minor text changes.
03-Sep-2013	4	– Updated: title and <a href="#">Figure 1</a> in the cover page. – Updated: <a href="#">Section 4: Package mechanical data</a> – Updated: <a href="#">Figure 13</a> , <a href="#">14</a> , <a href="#">15</a> and <a href="#">16</a> – Added new <a href="#">Table 4: Avalanche characteristics</a> . – Minor text changes – Document status promoted from preliminary to production data.

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